



Substitute for forms PTO/SB/08a & PTO/SB/08b

## INFORMATION DISCLOSURE STATEMENT BY APPLICANT

Sheet 1 OF 1

Application Number	10/701,832
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First Named Inventor	Elmer G. Fridrich
Art Unit	2879
Examiner Name	E. Rielley
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### U.S. PATENT DOCUMENTS

Exam. Initials	Cite No.	Document Number No.-Kind Code (if known)	Publication Date MM-DD-YYYY	Name of Patentee or Applicant of Cited Document	Relevant Pages, Columns, Lines
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*Elizabeth Rielley*  
Examiner Signature

3/18/06  
Date Considered